

BUK9V13-40H

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

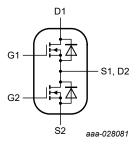
9 May 2023

Product data sheet

1. General description

Dual, logic level N-channel MOSFET in an LFPAK56D package (half-bridge configuration), using Trench 9 TrenchMOS technology. This product has been designed and qualified to AEC-Q101.

An internal connection is made between the source (S1) of the highside FET to the drain (D2) of the low-side FET, making the device ideal to use as a half-bridge switch in high-performance automotive PWM applications.



2. Features and benefits

- LFPAK56D package with half-bridge configuration enables:
 - Reduced PCB layout complexity
 - PCB shrinkage through reduced component footprint for 3-phase motor drive
 - Improved system level R_{th(j-amb)} due to optimized package design
 - Lower parasitic inductance to support higher efficiency
 - · Footprint compatibility with LFPAK56D Dual package
- Advanced AEC-Q101 grade Trench 9 silicon technology:
 - · Low power losses, high power density
 - Superior avalanche performance
 - Repetitive avalanche rated
- LFPAK copper clip packaging provides high robustness and reliability
- Gull wing leads support high manufacturability and Automated Optical Inspection (AOI)

3. Applications

- · 12 V automotive systems
- · Powertrain, chassis, body and infotainment applications
- Brushless or brushed DC motor drive
- DC-to-DC systems
- LED lighting

4. Quick reference data

Table 1. Quick reference data

Table 1. Quick	table 1. Quick reference data							
Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Limiting values FET1 and FET2								
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	40	V	
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	42	Α	
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	46	W	



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Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Static characte	Static characteristics FET1 and FET2							
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 25 °C; Fig. 11		7.9	11.35	13.6	mΩ	
Dynamic char	Dynamic characteristics FET1 and FET2							
Q_{GD}	gate-drain charge	I _D = 10 A; V _{DS} = 32 V; V _{GS} = 5 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	2.1	4.2	nC	
Source-drain diode FET1 and FET2								
Q _r	recovered charge	I_S = 10 A; dI_S/dt = -100 A/ μ s; V_{GS} = 0 V; V_{DS} = 20 V; T_j = 25 °C	[2]	-	16.2	-	nC	

^{[1] 42}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S2	source2	8 7 6 5	
2	G2	gate2	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	D1
3	S1, D2	source1, drain2		
4	G1	gate1		G1 — F
5	D1	drain1		S1, D2
6	D1	drain1		G2 LIFT
7	S1, D2	source1, drain2	1 2 3 4	
8	S1, D2	source1, drain2	LFPAK56D; Dual LFPAK (SOT1205)	S2 _{aaa-028081}

6. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BUK9V13-40H	LFPAK56D; Dual LFPAK	plastic, single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9V13-40H	9V1340H

^[2] includes capacitive recovery

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

	Conditions		Min	Max	Unit
T1 and FET2					
rain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	40	V
ate-source voltage	DC; T _j = 25 °C		-20	20	V
otal power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	46	W
rain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	42	Α
	V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>		-	30	Α
eak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 \text{ °C}$; Fig. 3		-	169	Α
torage temperature			-55	175	°C
inction temperature			-55	175	°C
e FET1 and FET2			1	'	
ource current	T _{mb} = 25 °C		-	42	Α
eak source current	pulsed; t _p ≤ 10 μs; T _{mb} = 25 °C		-	169	Α
ness FET1 and FET2					_
		[2] [3]	-	10.6	mJ
on-repetitive avalanche urrent	$V_{sup} = 40 \text{ V}; V_{GS} = 10 \text{ V}; T_{j(init)} = 25 \text{ °C};$ $R_{GS} = 50 \Omega; Fig. 4$	[4]	-	39.9	А
r	rain-source voltage rate-source voltage rate-source voltage rate-source voltage rain current rai	rain-source voltage $25 ^{\circ}\text{C} \le T_{j} \le 175 ^{\circ}\text{C}$ ate-source voltage $DC; T_{j} = 25 ^{\circ}\text{C}$ tal power dissipation $T_{mb} = 25 ^{\circ}\text{C}; Fig. 1$ $V_{GS} = 10 \text{V}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 2$ $V_{GS} = 10 \text{V}; T_{mb} = 100 ^{\circ}\text{C}; Fig. 2$ eak drain current $P_{mb} = 100 ^{\circ}\text{C}; P_{mb} = 25 ^{\circ}\text{C}; P_{$	rain-source voltage $25 ^{\circ}\text{C} \le T_{j} \le 175 ^{\circ}\text{C}$ ate-source voltage $DC; T_{j} = 25 ^{\circ}\text{C}$ tal power dissipation $T_{mb} = 25 ^{\circ}\text{C}; Fig. 1$ $V_{GS} = 10 \text{V}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 2$ [1] $V_{GS} = 10 \text{V}; T_{mb} = 100 ^{\circ}\text{C}; Fig. 2$ pulsed; $t_{p} \le 10 \mu\text{s}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 3$ orage temperature $V_{mb} = V_{mb} = $	rain-source voltage $25 ^{\circ}\text{C} \le T_j \le 175 ^{\circ}\text{C}$ -ate-source voltage $DC; T_j = 25 ^{\circ}\text{C}$ -20 tal power dissipation $T_{mb} = 25 ^{\circ}\text{C}; Fig. 1$ - rain current $V_{GS} = 10 ^{\circ}\text{V}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 2$ [1] - $V_{GS} = 10 ^{\circ}\text{V}; T_{mb} = 100 ^{\circ}\text{C}; Fig. 2$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 3$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 3$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 3$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 3$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 3$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{H}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 4$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 2$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 25 ^{\circ}\text{C}; Fig. 2$ - rain current pulsed; $t_p \le 10 ^{\circ}\text{C}; T_{mb} = 10 ^{\circ}\text{C}; T_{mb} = 10 ^{\circ}\text{C}; T_{mb} = 10 $	rain-source voltage $25 \text{ °C} \le T_j \le 175 \text{ °C}$ $-20 20$ -20

^{[1] 42}A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

- [2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [3] Refer to application note AN10273 for further information.
- [4] Protected by 100% test

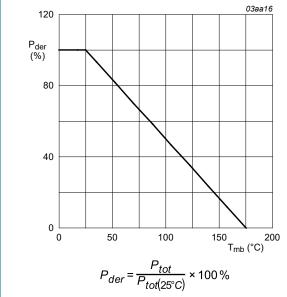
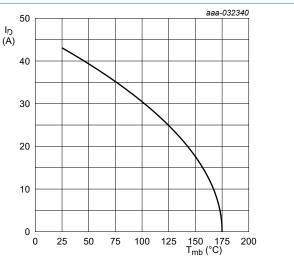


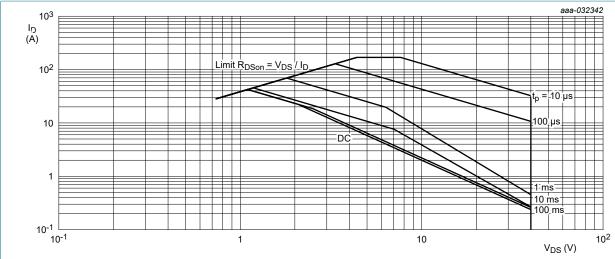
Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$ 42A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)



T_{mb} = 25 °C; I_{DM} is a single pulse

Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage, FET1 and FET2

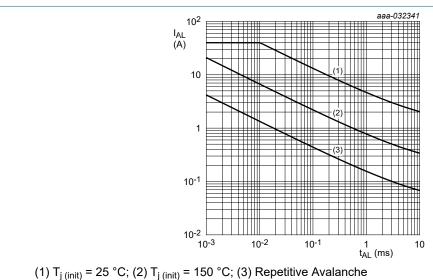


Fig. 4. Avalanche rating; avalanche current as a function of avalanche time, FET1 and FET2

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 5	-	3	3.23	K/W

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

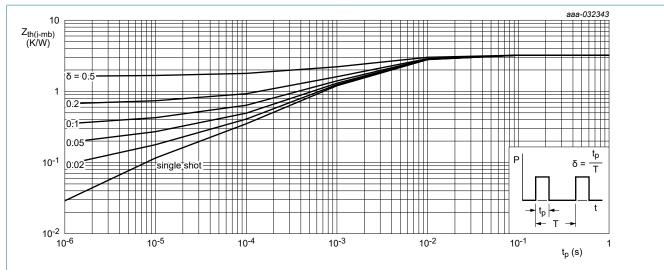


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FET2

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics FET1 and FET2					
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	40	43	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C	-	40.5	-	V
		I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	36	40	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}; Fig. 9;$ Fig. 10	1.5	1.85	2.2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 10	0.7	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C}; Fig. 10$	-	-	2.6	V
I _{DSS}	drain leakage current	V _{DS} = 40 V; V _{GS} = 0 V; T _j = 25 °C	-	0.01	5	μΑ
		V _{DS} = 16 V; V _{GS} = 0 V; T _j = 125 °C	-	0.14	10	μΑ
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	26	500	μΑ
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -10 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ Fig. 11		7.9	11.35	13.6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 10 \text{ A}; T_j = 105 ^{\circ}\text{C};$ Fig. 12		10.9	16.87	20.4	mΩ
		V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 125 °C; Fig. 12		12	18.2	21.9	mΩ
		V_{GS} = 10 V; I_{D} = 10 A; T_{j} = 175 °C; Fig. 12		14.5	21.97	26.4	mΩ
		V_{GS} = 4.5 V; I_{D} = 10 A; T_{j} = 25 °C; Fig. 11		9.8	14.04	16.9	mΩ
		V_{GS} = 4.5 V; I_{D} = 10 A; T_{j} = 105 °C; Fig. 12		13.5	20.6	25.4	mΩ
		V_{GS} = 4.5 V; I_{D} = 10 A; T_{j} = 125 °C; Fig. 12		14.8	22.24	27.2	mΩ
		V_{GS} = 4.5 V; I_{D} = 10 A; T_{j} = 175 °C; Fig. 12		18	26.65	32.8	mΩ
R_G	gate resistance	f = 1 MHz; T _j = 25 °C		0.7	1.7	4.2	Ω
Dynamic ch	naracteristics FET1 and FE	T2			'		
Q _{G(tot)}	total gate charge	I _D = 10 A; V _{DS} = 32 V; V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	13.9	19.4	nC
		I _D = 10 A; V _{DS} = 32 V; V _{GS} = 5 V;		-	7.3	10.2	nC
Q _{GS}	gate-source charge	T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		-	2.5	3.8	nC
Q _{GD}	gate-drain charge			-	2.1	4.2	nC
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;		-	829	1160	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 15</u>		-	280	420	pF
C _{rss}	reverse transfer capacitance			-	38	84	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 3 \Omega; V_{GS} = 5 \text{ V};$		-	5.6	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 ^{\circ}C$		-	8.1	-	ns
t _{d(off)}	turn-off delay time			-	9.1	-	ns
t _f	fall time	1		-	6.5	-	ns
Source-drai	in diode FET1 and FET2	1	1	1		1	
V _{SD}	source-drain voltage	I _S = 10 A; V _{GS} = 0 V; T _j = 25 °C; <u>Fig. 16</u>		-	0.84	1	V
t _{rr}	reverse recovery time	$I_S = 10 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$		-	21.5	-	ns
Q _r	recovered charge	V _{DS} = 20 V; T _j = 25 °C	[1]	-	16.2	-	nC
		1	1			1	

^[1] includes capacitive recovery

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

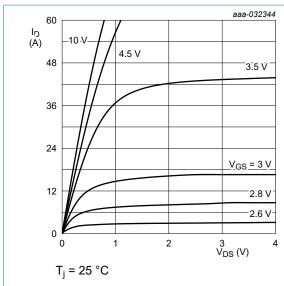


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values, FET1 and FET2

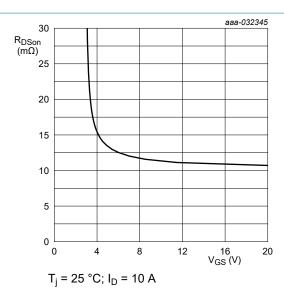


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values, FET1 and FET2

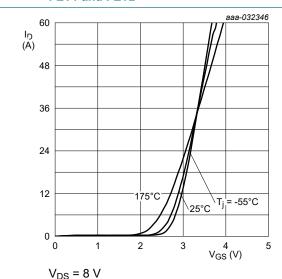


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values, FET1 and FET2

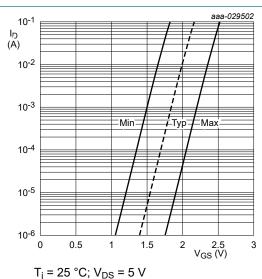


Fig. 9. Sub-threshold drain current as a function of gate-source voltage, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

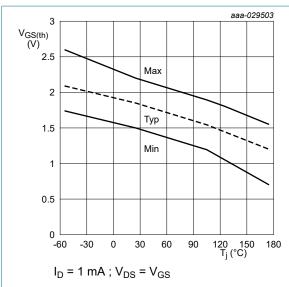


Fig. 10. Gate-source threshold voltage as a function of junction temperature, FET1 and FET2

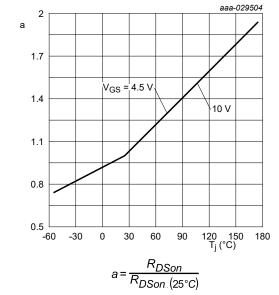


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

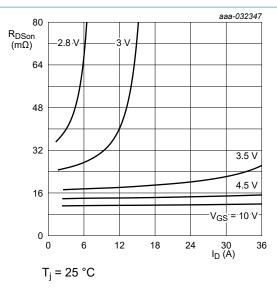


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

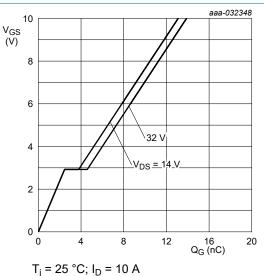


Fig. 13. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

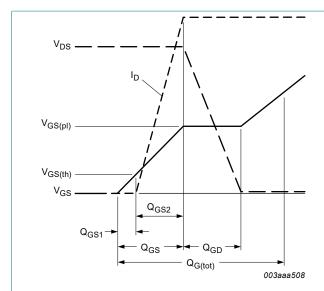


Fig. 14. Gate charge waveform definitions

 $V_{GS} = 0 V$

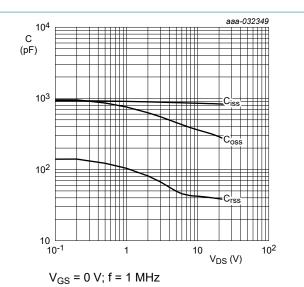


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2

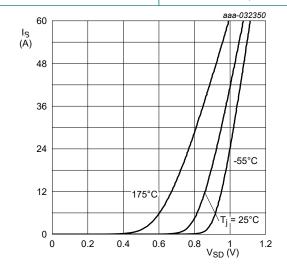


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values, FET1 and FET2

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

11. Package outline

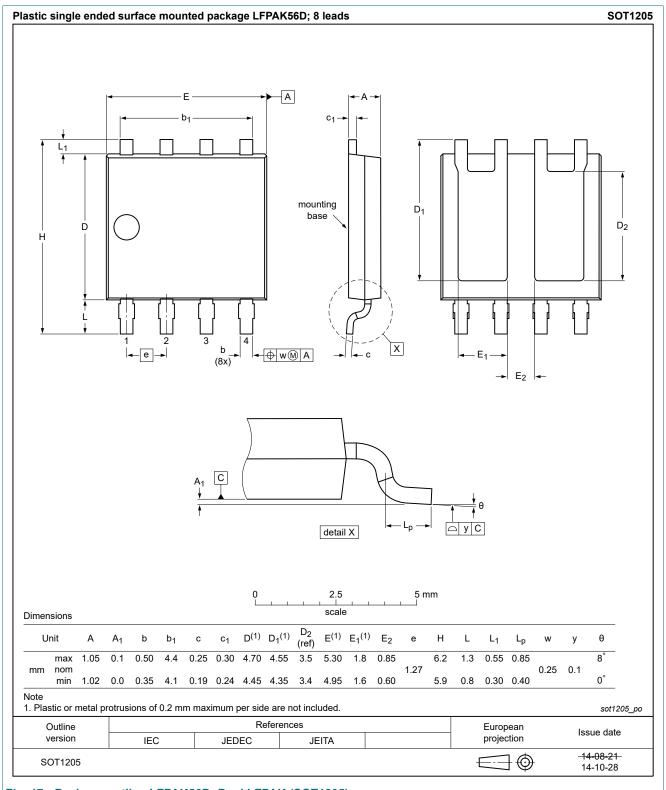
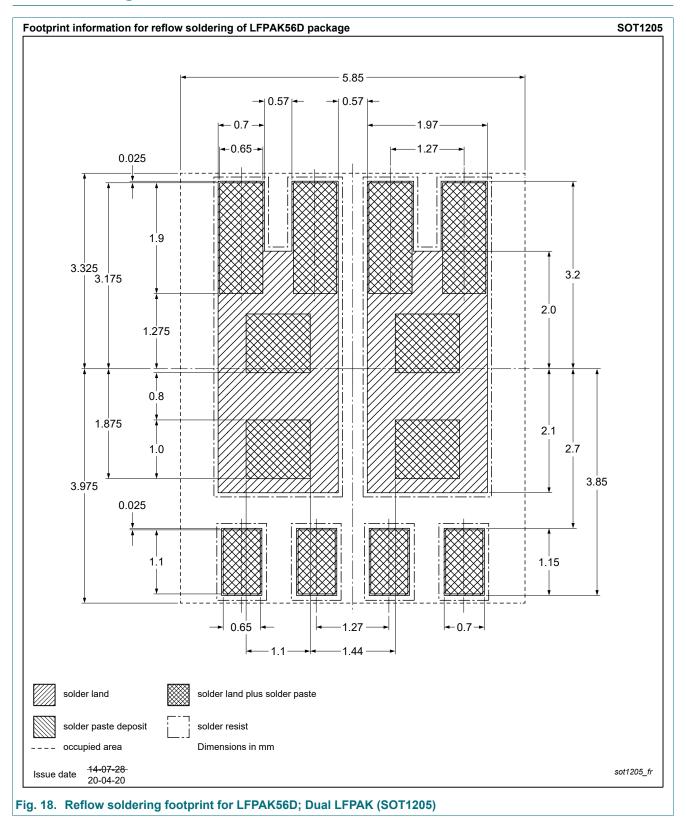


Fig. 17. Package outline LFPAK56D; Dual LFPAK (SOT1205)

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

12. Soldering



Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
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BUK9V13-40H

Dual N-channel 40 V, 13 mOhm logic level MOSFET in LFPAK56D (half-bridge configuration)

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